

## 适用于汽车的 TS3A5017-Q1 双通道 4:1 模拟开关 转换器

### 1 特性

- 符合面向汽车应用的 AEC-Q100 标准
  - 器件温度范围:  $-40^{\circ}\text{C}$  至  $125^{\circ}\text{C}$ ,  $T_A$
  - 器件 HBM 分类等级:  $\pm 1500\text{V}$
  - 器件 CDM 分类等级:  $\pm 1000\text{V}$
- 支持关断保护, 当  $V_{CC} = 0\text{V}$  时, I/O 引脚处于高阻抗状态
- 低导通状态电阻
- 低电荷注入
- $1\Omega$  通态电阻匹配
- 0.25% 总谐波失真 (THD+N)
- 2.3V 至 3.6V 单电源运行
- 锁断性能超过 100mA, 符合 JESD 78 II 类规范的要求

### 2 应用

- 采样和保持电路
- 信息娱乐音频和视频信号路由
- 远程信息处理控制单元

### 3 说明

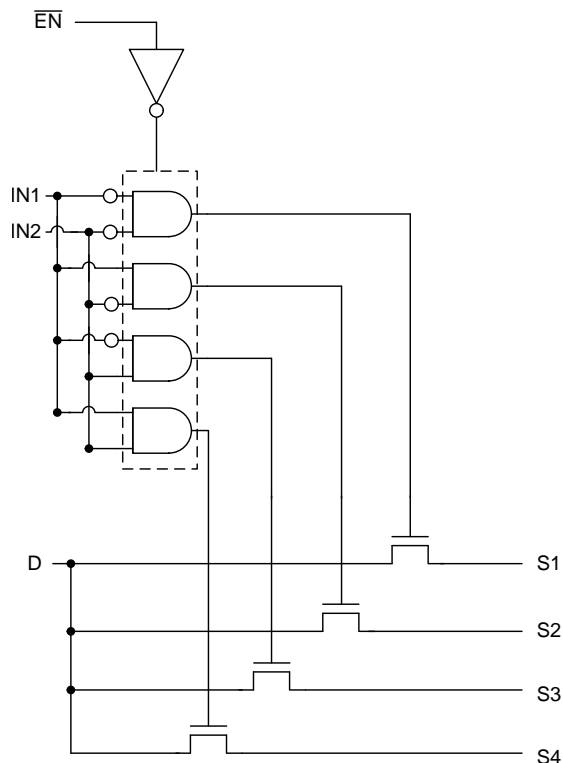
TS3A5017-Q1 器件是一款双通道 4:1 多路复用器, 其设计工作电压为 2.3V 至 3.6V。该器件是一款双向器件, 可以处理数字和模拟信号。该器件的断电保护功能可确保  $V_{CC} = 0\text{V}$  时信号路径为高阻抗, 从而简化了电源定序, 并提高了系统可靠性。

器件信息(1)

器件编号	封装	封装尺寸 (标称值)
TS3A5017-Q1	VQFN (16)	4.00mm × 3.50mm

(1) 如需了解所有可用封装, 请参阅数据表末尾的可订购产品附录。

方框图



## 目录

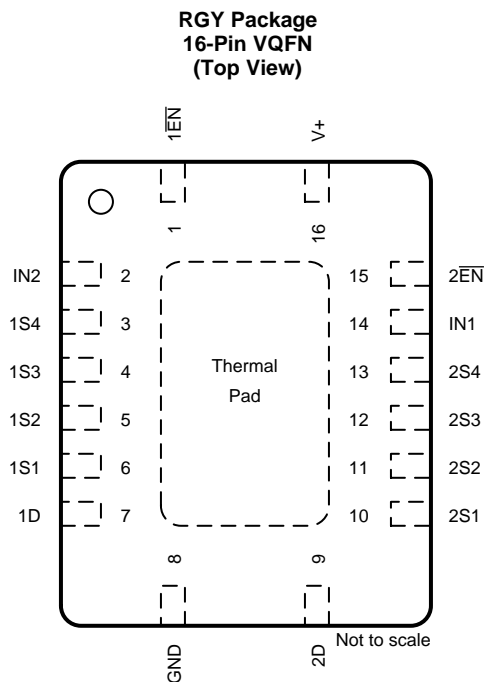
<b>1</b>	特性 .....	<b>1</b>	8.3	Feature Description .....	<b>15</b>
<b>2</b>	应用 .....	<b>1</b>	8.4	Device Functional Modes .....	<b>15</b>
<b>3</b>	说明 .....	<b>1</b>	<b>9</b>	<b>Application and Implementation .....</b>	<b>16</b>
<b>4</b>	修订历史记录 .....	<b>2</b>	9.1	Application Information .....	<b>16</b>
<b>5</b>	<b>Pin Configuration and Functions .....</b>	<b>3</b>	9.2	Typical Application .....	<b>16</b>
<b>6</b>	<b>Specifications .....</b>	<b>4</b>	<b>10</b>	<b>Power Supply Recommendations .....</b>	<b>17</b>
6.1	Absolute Maximum Ratings .....	<b>4</b>	<b>11</b>	<b>Layout .....</b>	<b>18</b>
6.2	ESD Ratings .....	<b>4</b>	11.1	Layout Guidelines .....	<b>18</b>
6.3	Recommended Operating Conditions .....	<b>4</b>	11.2	Layout Example .....	<b>18</b>
6.4	Thermal Information .....	<b>4</b>	<b>12</b>	<b>器件和文档支持 .....</b>	<b>19</b>
6.5	Electrical Characteristics for 3.3-VSupply .....	<b>5</b>	12.1	器件支持 .....	<b>19</b>
6.6	Electrical Characteristics for 2.5-VSupply .....	<b>6</b>	12.2	文档支持 .....	<b>19</b>
6.7	Switching Characteristics for 3.3-VSupply .....	<b>8</b>	12.3	接收文档更新通知 .....	<b>20</b>
6.8	Switching Characteristics for 2.5-VSupply .....	<b>8</b>	12.4	社区资源 .....	<b>20</b>
6.9	Typical Characteristics .....	<b>9</b>	12.5	商标 .....	<b>20</b>
<b>7</b>	<b>Parameter Measurement Information .....</b>	<b>11</b>	12.6	静电放电警告 .....	<b>20</b>
<b>8</b>	<b>Detailed Description .....</b>	<b>15</b>	12.7	术语表 .....	<b>20</b>
8.1	Overview .....	<b>15</b>	<b>13</b>	<b>机械、封装和可订购信息 .....</b>	<b>20</b>
8.2	Functional Block Diagram .....	<b>15</b>			

## 4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

日期	修订版本	说明
2018 年 10 月	*	最初发布版本

## 5 Pin Configuration and Functions



If exposed thermal pad is used, it must be connected as a secondary ground or left electrically open.

### Pin Functions

PIN		TYPE	DESCRIPTION
NO.	NAME		
7	1D	I/O	Common path for switch 1
1	$\overline{1EN}$	I	Active-low enable for switch 1
6	1S1	I/O	Switch 1 channel 1
5	1S2	I/O	Switch 1 channel 2
4	1S3	I/O	Switch 1 channel 3
3	1S4	I/O	Switch 1 channel 4
9	2D	I/O	Common path for switch 2
15	$\overline{2EN}$	I	Active-low enable for switch 2
10	2S1	I/O	Switch 2 channel 1
11	2S2	I/O	Switch 2 channel 2
12	2S3	I/O	Switch 2 channel 3
13	2S4	I/O	Switch 2 channel 4
8	GND	–	Ground
14	IN1	I	Switch 1 input select
2	IN2	I	Switch 2 input select
16	V+	–	Supply voltage

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1) (2)</sup>

			MIN	MAX	UNIT
V <sub>+</sub>	Supply voltage <sup>(3)</sup>		-0.5	4.6	V
V <sub>S</sub> , V <sub>D</sub>	Analog voltage <sup>(3) (4)</sup>		-0.5	4.6	V
I <sub>SK</sub> , I <sub>DK</sub>	Analog port clamp current	V <sub>S</sub> , V <sub>D</sub> < 0	-50		mA
I <sub>S</sub> , I <sub>D</sub>	ON-state switch current	V <sub>S</sub> , V <sub>D</sub> = 0 to 7 V	-128	128	mA
V <sub>I</sub>	Digital input voltage		-0.5	4.6	V
I <sub>IK</sub>	Digital input clamp current <sup>(3) (4)</sup>	V <sub>I</sub> < 0	-50		mA
I <sub>+</sub>	Continuous current through V <sub>+</sub>			100	mA
I <sub>GND</sub>	Continuous current through GND		-100		mA
T <sub>stg</sub>	Storage temperature		-65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
- (3) All voltages are with respect to ground, unless otherwise specified.
- (4) The input and output voltage ratings may be exceeded if their input and output clamp-current ratings are observed.

### 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1500	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V <sub>I/O</sub>	Switch input/output voltage range	0	3.6	V
V <sub>+</sub>	Supply voltage range	2.3	3.6	V
V <sub>I</sub>	Control input voltage range	0	3.6	V
T <sub>A</sub>	Operating Temperature Range	-40	125	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TS3A5017-Q1	UNIT
		RGY (VQFN)	
		16 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	47.1	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	58.5	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	24.0	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	1.8	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	24.0	°C/W

- (1) For more information about traditional and new thermal metrics, see the [IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics for 3.3-V Supply

 $V_+ = 2.7\text{ V to }3.6\text{ V}$ ,  $T_A = -40^\circ\text{C to }125^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
<b>Analog Switch</b>								
$V_D, V_S$	Analog signal range				0		$V_+$	V
$r_{on}$	ON-state resistance	$0 \leq V_S \leq V_+$ , $I_D = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3\text{ V}$		11		$\Omega$
				$T_A = \text{Full}$ $V_+ = 3\text{ V}$			16	
$\Delta r_{on}$	ON-state resistance match between channels	$V_S = 2.1\text{ V}$ , $I_D = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3\text{ V}$		1		$\Omega$
				$T_A = \text{Full}$ $V_+ = 3\text{ V}$			5	
$r_{on(\text{flat})}$	ON-state resistance flatness	$0 \leq V_S \leq V_+$ , $I_D = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3\text{ V}$		7		$\Omega$
				$T_A = \text{Full}$ $V_+ = 3\text{ V}$			12	
$I_{S(\text{OFF})}$	S OFF leakage current	$V_S = 1\text{ V}, V_D = 3\text{ V}$ , or $V_S = 3\text{ V}, V_D = 1\text{ V}$ ,	Switch OFF, see <a href="#">Figure 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.6\text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6\text{ V}$			-0.3	
$I_{SPWR(\text{OFF})}$		$V_S = 0\text{ to }3.6\text{ V}$ , $V_D = 3.6\text{ V to }0$ ,	Switch OFF, see <a href="#">Figure 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 0\text{ V}$		0.5		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 0\text{ V}$			-10	
$I_{D(\text{OFF})}$	D OFF leakage current	$V_S = 1\text{ V}, V_D = 3\text{ V}$ , or $V_S = 3\text{ V}, V_D = 1\text{ V}$ ,	Switch OFF, see <a href="#">Figure 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.6\text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6\text{ V}$			-0.3	
$I_{DPWR(\text{OFF})}$		$V_D = 0\text{ to }3.6\text{ V}$ , $V_S = 3.6\text{ V to }0$ ,	Switch OFF, see <a href="#">Figure 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 0\text{ V}$		0.5		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 0\text{ V}$			-20	
$I_{S(\text{ON})}$	S ON leakage current	$V_S = 1\text{ V}, V_D = \text{Open}$ , or $V_S = 3\text{ V}, V_D = \text{Open}$ ,	Switch ON, see <a href="#">Figure 14</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.6\text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6\text{ V}$			-0.3	
$I_{D(\text{ON})}$	D ON leakage current	$V_D = 1\text{ V}, V_S = \text{Open}$ , or $V_D = 3\text{ V}, V_S = \text{Open}$ ,	Switch ON, see <a href="#">Figure 14</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.6\text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6\text{ V}$			-0.3	
<b>Digital Control Inputs (IN1, IN2, EN)<sup>(2)</sup></b>								
$V_{IH}$	Input logic high			$T_A = \text{Full}$	2		$V_+$	V
$V_{IL}$	Input logic low			$T_A = \text{Full}$	0		0.8	V
$I_{IH}, I_{IL}$	Input leakage current	$V_I = V_+ \text{ or } 0$		$T_A = 25^\circ\text{C}$ $V_+ = 3.6\text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6\text{ V}$			-1	
$Q_C$	Charge injection	$V_{GEN} = 0, R_{GEN} = 0$ , $C_L = 0.1\text{ nF}$ ,	See <a href="#">Figure 21</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3\text{ V}$		5		pC
$C_{S(\text{OFF})}$	S OFF capacitance	$V_S = V_+ \text{ or GND}$ , Switch OFF,	See <a href="#">Figure 15</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3\text{ V}$		4.5		pF
$C_{D(\text{OFF})}$	D OFF capacitance	$V_D = V_+ \text{ or GND}$ , Switch OFF,	See <a href="#">Figure 15</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3\text{ V}$		19		pF
$C_{S(\text{ON})}$	S ON capacitance	$V_S = V_+ \text{ or GND}$ , Switch ON,	See <a href="#">Figure 15</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3\text{ V}$		27		pF

(1) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

(2) All unused digital inputs of the device must be held at  $V_+$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## Electrical Characteristics for 3.3-V Supply (continued)

 $V_+ = 2.7 \text{ V to } 3.6 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 125^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$C_{D(ON)}$	D ON capacitance	$V_D = V_+$ or GND, Switch ON,	See <a href="#">Figure 15</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		27		pF
$C_I$	Digital input capacitance	$V_I = V_+$ or GND,	See <a href="#">Figure 15</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		3		pF
BW	Bandwidth	$R_L = 50 \Omega$ , Switch ON,	See <a href="#">Figure 17</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		165		MHz
$O_{ISO}$	OFF isolation	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">Figure 18</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		-69		dB
$O_{ISO}$	OFF isolation	$R_L = 50 \Omega$ , $f = 10 \text{ MHz}$ ,	See <a href="#">Figure 18</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		-49		dB
$X_{TALK}$	Crosstalk	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">Figure 19</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		-69		dB
$X_{TALK(ADJ)}$	Crosstalk adjacent	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">Figure 20</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		-80		dB
THD	Total harmonic distortion	$R_L = 600 \Omega$ , $C_L = 50 \text{ pF}$ ,	$f = 20 \text{ Hz to } 20 \text{ kHz}$ , see <a href="#">Figure 22</a>	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$		0.25		%
<b>Supply</b>								
$I_+$	Positive supply current	$V_I = V_+$ or GND,	Switch ON or OFF	$T_A = 25^\circ\text{C}$ $V_+ = 3.6 \text{ V}$		2.5	7	$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 3.6 \text{ V}$			10	

## 6.6 Electrical Characteristics for 2.5-V Supply

 $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 125^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
<b>Analog Switch</b>								
$V_D, V_S$	Analog signal range				0		$V_+$	V
$r_{on}$	ON-state resistance	$0 \leq V_S \leq V_+$ , $I_D = -24 \text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.3 \text{ V}$		22		$\Omega$
				$T_A = \text{Full}$ $V_+ = 2.3 \text{ V}$			28	
$\Delta r_{on}$	ON-state resistance match between channels	$V_S = 1.6 \text{ V}$ , $I_D = -24 \text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.3 \text{ V}$		1		$\Omega$
				$T_A = \text{Full}$ $V_+ = 2.3 \text{ V}$			5	
$r_{on(\text{flat})}$	ON-state resistance flatness	$0 \leq V_S \leq V_+$ , $I_D = -24 \text{ mA}$ ,	Switch ON, see <a href="#">Figure 12</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.3 \text{ V}$		18		$\Omega$
				$T_A = \text{Full}$ $V_+ = 2.3 \text{ V}$			24	
$I_{S(\text{OFF})}$	S OFF leakage current	$V_S = 0.5 \text{ V}$ , $V_D = 2.2 \text{ V}$ , or $V_S = 2.2 \text{ V}$ , $V_D = 0.5 \text{ V}$ ,	Switch OFF, see <a href="#">Figure 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.7 \text{ V}$		0.05		$\mu\text{A}$
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$		-0.3	0.3	
$I_{SPWR(\text{OFF})}$		$V_S = 0 \text{ to } 2.7 \text{ V}$ , $V_D = 2.7 \text{ V to } 0$ ,		$T_A = 25^\circ\text{C}$ $V_+ = 0 \text{ V}$		0.5		
				$T_A = \text{Full}$ $V_+ = 0 \text{ V}$		-15	15	

(1) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum

**Electrical Characteristics for 2.5-V Supply (continued)**
 $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 125^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$I_{D(OFF)}$	D OFF leakage current	$V_S = 0.5 \text{ V}$ , $V_D = 2.2 \text{ V}$ , or $V_S = 2.2 \text{ V}$ , $V_D = 0.5 \text{ V}$ ,	Switch OFF, see <a href="#">图 13</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.7 \text{ V}$	0.05		$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$	-0.3	0.3		
$I_{DPWR(OFF)}$		$V_D = 0 \text{ to } 2.7 \text{ V}$ , $V_S = 2.7 \text{ V to } 0$ ,		$T_A = 25^\circ\text{C}$ $V_+ = 0 \text{ V}$	0.5		$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 0 \text{ V}$	-20	20		
$I_{S(ON)}$	S ON leakage current	$V_S = 0.5 \text{ V}$ , $V_D = \text{Open}$ , or $V_S = 2.2 \text{ V}$ , $V_D = \text{Open}$ ,	Switch ON, see <a href="#">图 14</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.7 \text{ V}$	0.05		$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$	-0.3	0.3		
$I_{D(ON)}$	D ON leakage current	$V_D = 0.5 \text{ V}$ , $V_S = \text{Open}$ , or $V_D = 2.2 \text{ V}$ , $V_S = \text{Open}$ ,	Switch ON, see <a href="#">图 14</a>	$T_A = 25^\circ\text{C}$ $V_+ = 2.7 \text{ V}$	0.05		$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$	-0.3	0.3		
<b>Logic Inputs (IN1, IN2, EN)<sup>(2)</sup></b>								
$V_{IH}$	Input logic high			$T_A = \text{Full}$	1.7	$V_+$	V	
$V_{IL}$	Input logic low			$T_A = \text{Full}$	0	0.7	V	
$I_{IH}$ , $I_{IL}$	Input leakage current	$V_I = V_+ \text{ or } 0$		$T_A = 25^\circ\text{C}$ $V_+ = 2.7 \text{ V}$	0.05		$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$	-1	1		
$Q_C$	Charge injection	$V_{GEN} = 0$ , $R_{GEN} = 0$ , $C_L = 0.1 \text{ nF}$ ,	See <a href="#">图 21</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	3		pC	
$C_{S(OFF)}$	S OFF capacitance	$V_S = V_+ \text{ or GND}$ , Switch OFF,	See <a href="#">图 15</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	4.5		pF	
$C_{D(OFF)}$	D OFF capacitance	$V_D = V_+ \text{ or GND}$ , Switch OFF,	See <a href="#">图 15</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	18.5		pF	
$C_{S(ON)}$	S ON capacitance	$V_S = V_+ \text{ or GND}$ , Switch ON,	See <a href="#">图 15</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	26		pF	
$C_{D(ON)}$	D ON capacitance	$V_D = V_+ \text{ or GND}$ , Switch ON,	See <a href="#">图 15</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	26		pF	
$C_I$	Digital input capacitance	$V_I = V_+ \text{ or GND}$ ,	See <a href="#">图 15</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	3		pF	
BW	Bandwidth	$R_L = 50 \Omega$ , Switch ON,	See <a href="#">图 17</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	165		MHz	
$O_{ISO}$	OFF isolation	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">图 18</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	-69		dB	
$O_{ISO}$	OFF isolation	$R_L = 50 \Omega$ , $f = 10 \text{ MHz}$ ,	See <a href="#">图 18</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	-49		dB	
$X_{TALK}$	Crosstalk	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">图 19</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	-69		dB	
$X_{TALK(ADJ)}$	Crosstalk adjacent	$R_L = 50 \Omega$ , $f = 1 \text{ MHz}$ ,	See <a href="#">图 20</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	-85		dB	
THD	Total harmonic distortion	$R_L = 600 \Omega$ , $C_L = 50 \text{ pF}$ ,	$f = 20 \text{ Hz to } 20 \text{ kHz}$ , see <a href="#">图 22</a>	$T_A = \text{Full}$ $V_+ = 2.5 \text{ V}$	0.3		%	
<b>Supply</b>								

(2) All unused digital inputs of the device must be held at  $V_+$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## Electrical Characteristics for 2.5-V Supply (continued)

 $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 125^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$I_+$	Positive supply current	$V_I = V_+$ or GND,	Switch ON or OFF	$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$	2.5	7	$\mu\text{A}$	
				$T_A = \text{Full}$ $V_+ = 2.7 \text{ V}$				

### 6.7 Switching Characteristics for 3.3-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$t_{\text{ON}}$	Turnon time <sup>(1)</sup>	$V_D = 2 \text{ V}$ , $R_L = 300 \Omega$ ,	$C_L = 35 \text{ pF}$ , see 图 16	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$	5	9.5	ns	
				$T_A = \text{Full}$ $V_+ = 3 \text{ V to } 3.6 \text{ V}$				
$t_{\text{OFF}}$	Turnoff time <sup>(1)</sup>	$V_D = 2 \text{ V}$ , $R_L = 300 \Omega$ ,	$C_L = 35 \text{ pF}$ , see 图 16	$T_A = 25^\circ\text{C}$ $V_+ = 3.3 \text{ V}$	1.5	3.5	ns	
				$T_A = \text{Full}$ $V_+ = 3 \text{ V to } 3.6 \text{ V}$				

(1) Specified by design, not tested in production

### 6.8 Switching Characteristics for 2.5-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$t_{\text{ON}}$	Turnon time <sup>(1)</sup>	$V_{\text{COM}} = 2 \text{ V}$ , $R_L = 300 \Omega$ ,	$C_L = 35 \text{ pF}$ , see 图 16	$T_A = 25^\circ\text{C}$ $V_+ = 2.5 \text{ V}$	5	8	ns	
				$T_A = \text{Full}$ $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$				
$t_{\text{OFF}}$	Turnoff time <sup>(1)</sup>	$V_{\text{COM}} = 2 \text{ V}$ , $R_L = 300 \Omega$ ,	$C_L = 35 \text{ pF}$ , see 图 16	$T_A = 25^\circ\text{C}$ $V_+ = 2.5 \text{ V}$	2	4.5	ns	
				$T_A = \text{Full}$ $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$				

(1) Specified by design, not tested in production.



### 6.9 Typical Characteristics

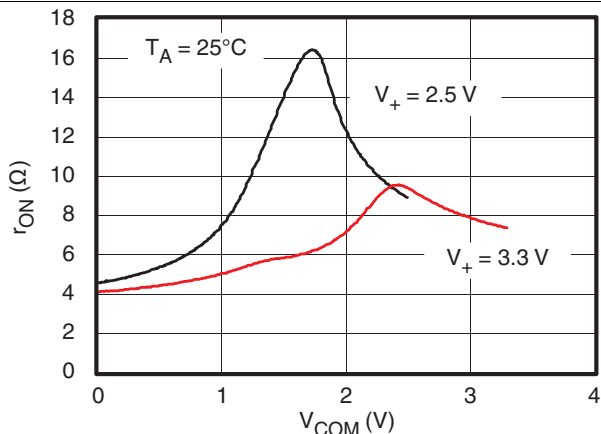


图 1.  $r_{ON}$  vs  $V_{COM}$

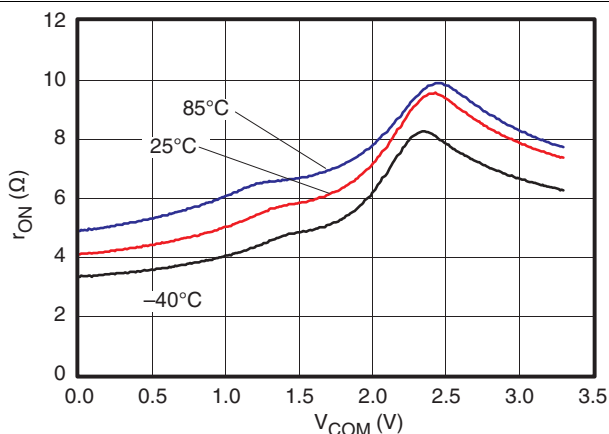


图 2.  $r_{ON}$  vs  $V_{COM}$  ( $V_+ = 3.3$  V)

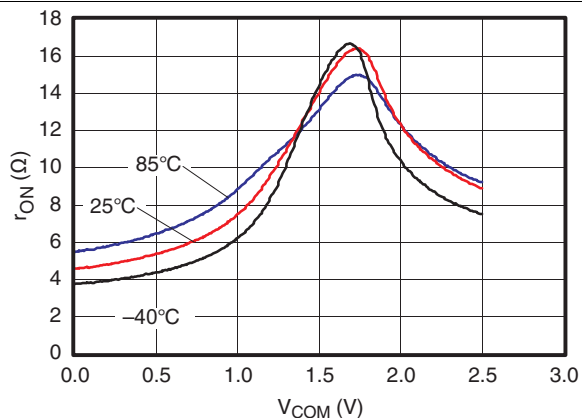


图 3.  $r_{ON}$  vs  $V_{COM}$  ( $V_+ = 2.5$  V)

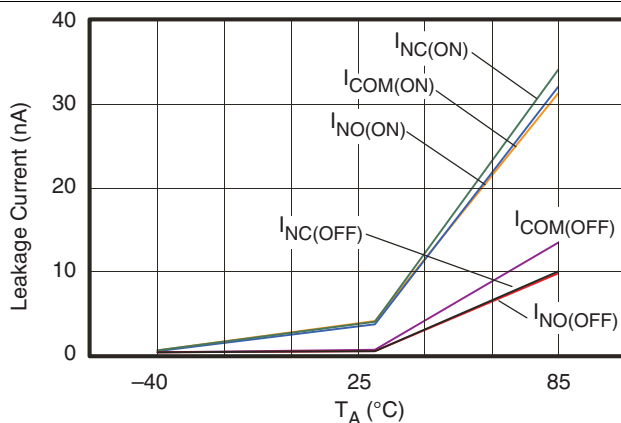


图 4. Leakage Current vs Temperature ( $V_+ = 3.6$  V)

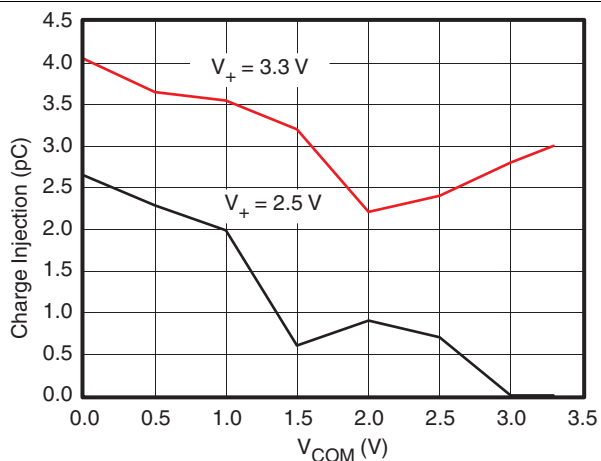


图 5. Charge Injection ( $Q_C$ ) vs  $V_{COM}$

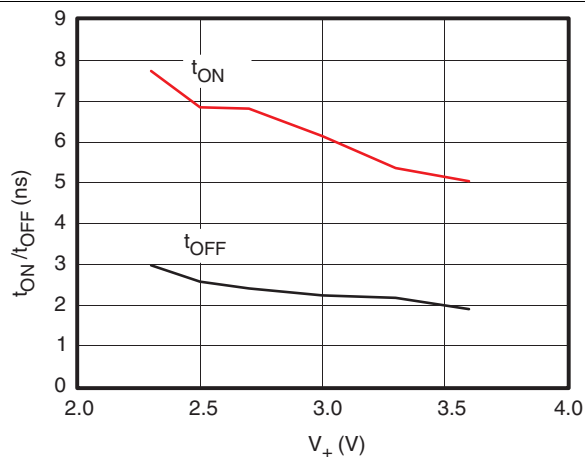
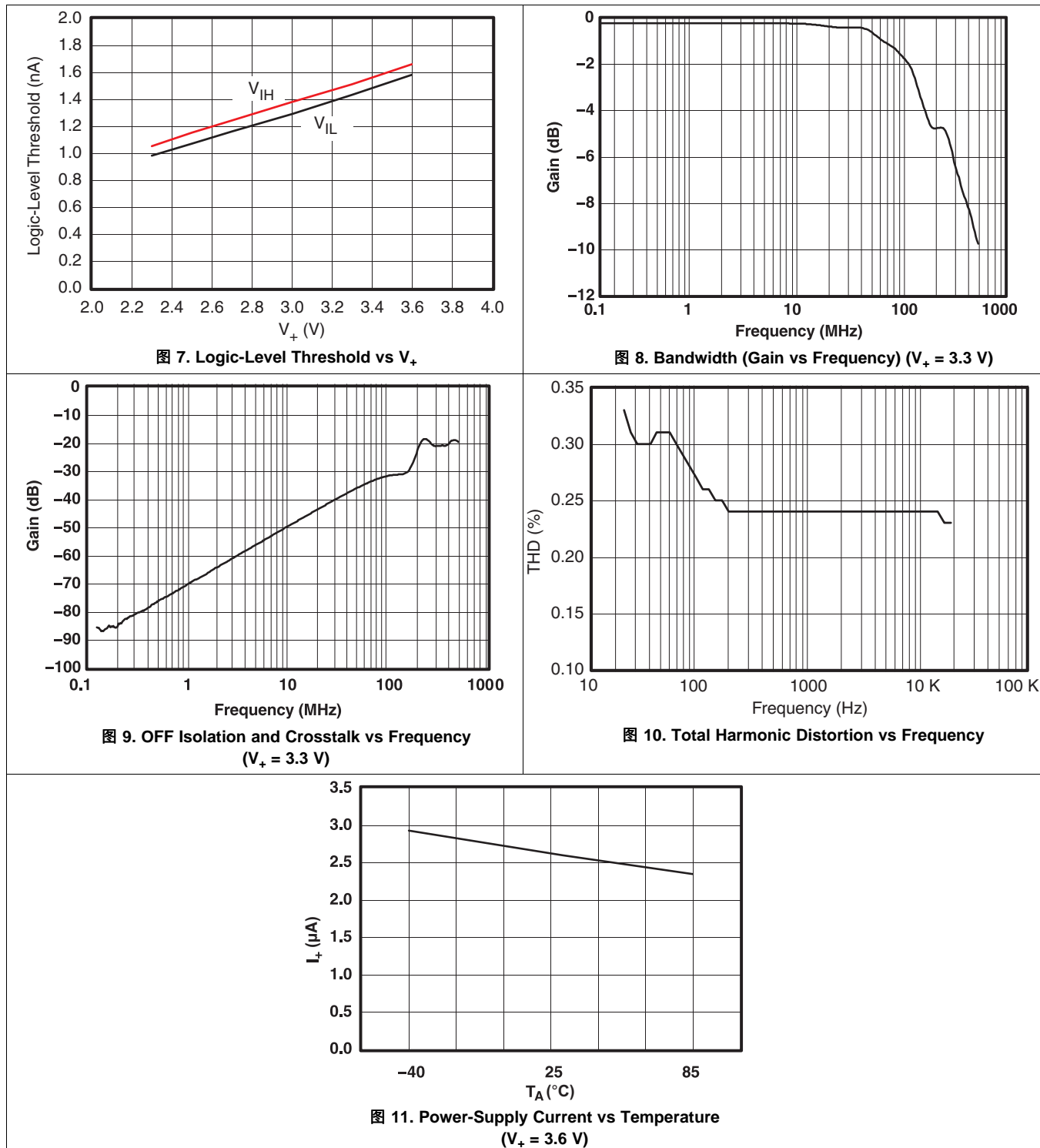


图 6.  $t_{ON}$  and  $t_{OFF}$  vs Supply Voltage

Typical Characteristics (接下页)



## 7 Parameter Measurement Information

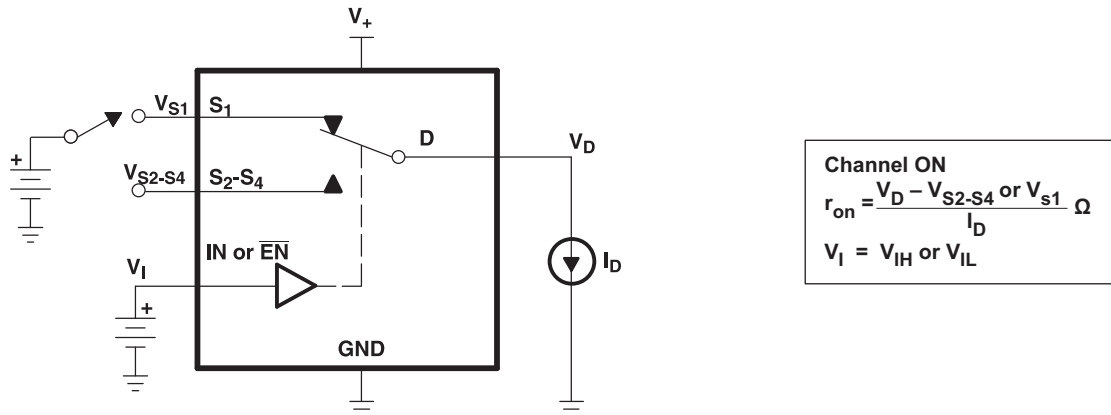


图 12. ON-State Resistance ( $r_{on}$ )

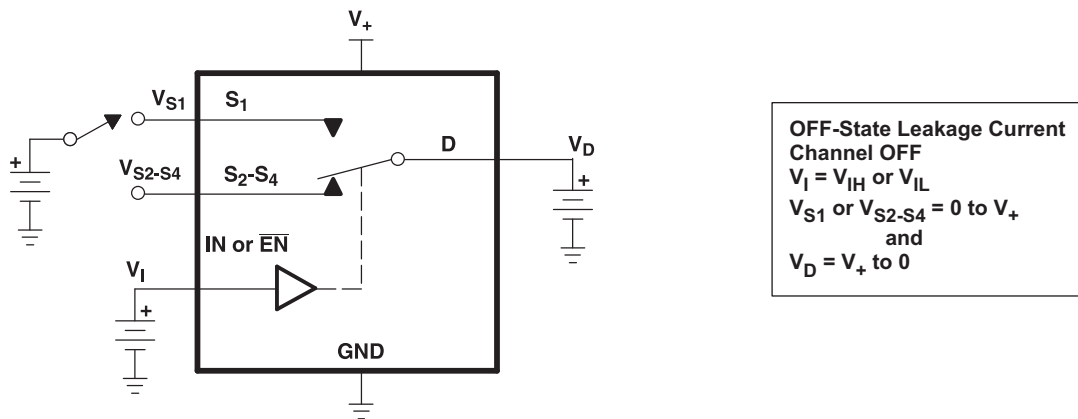


图 13. OFF-State Leakage Current ( $I_{D(OFF)}$ ,  $I_{S(OFF)}$ )

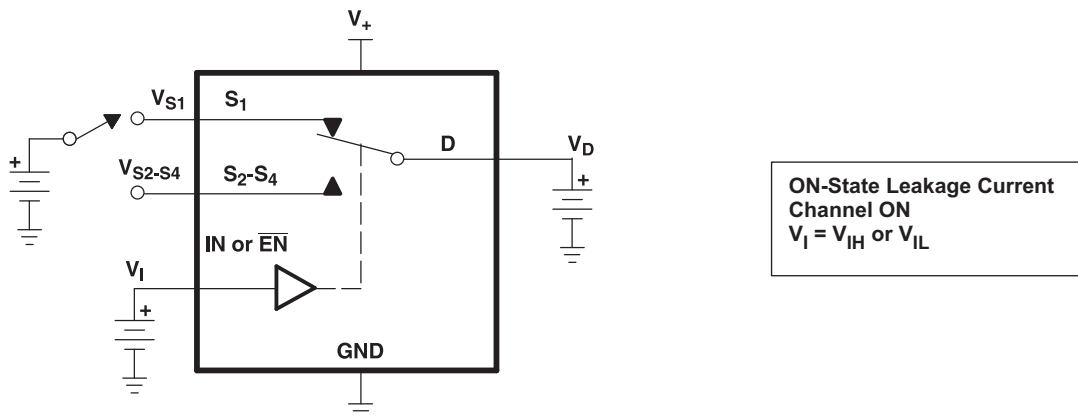


图 14. ON-State Leakage Current ( $I_{D(ON)}$ ,  $I_{S(ON)}$ )

Parameter Measurement Information (接下页)

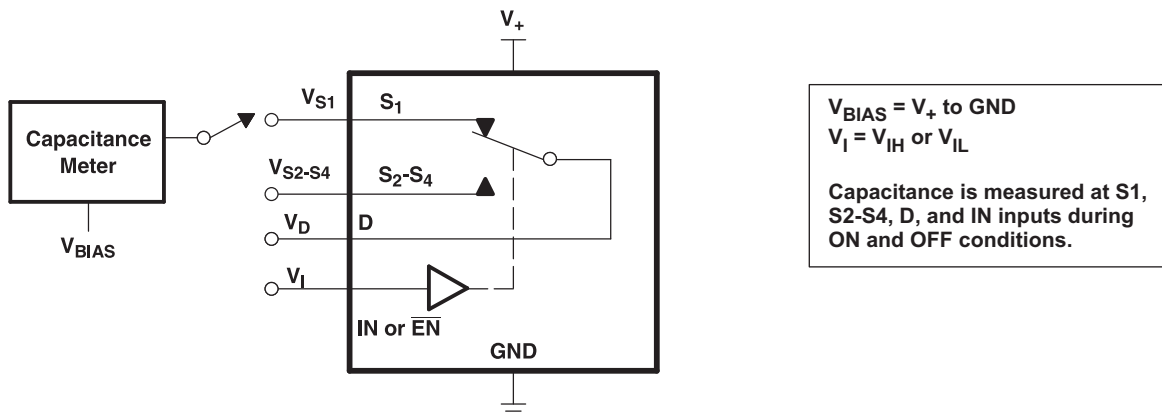
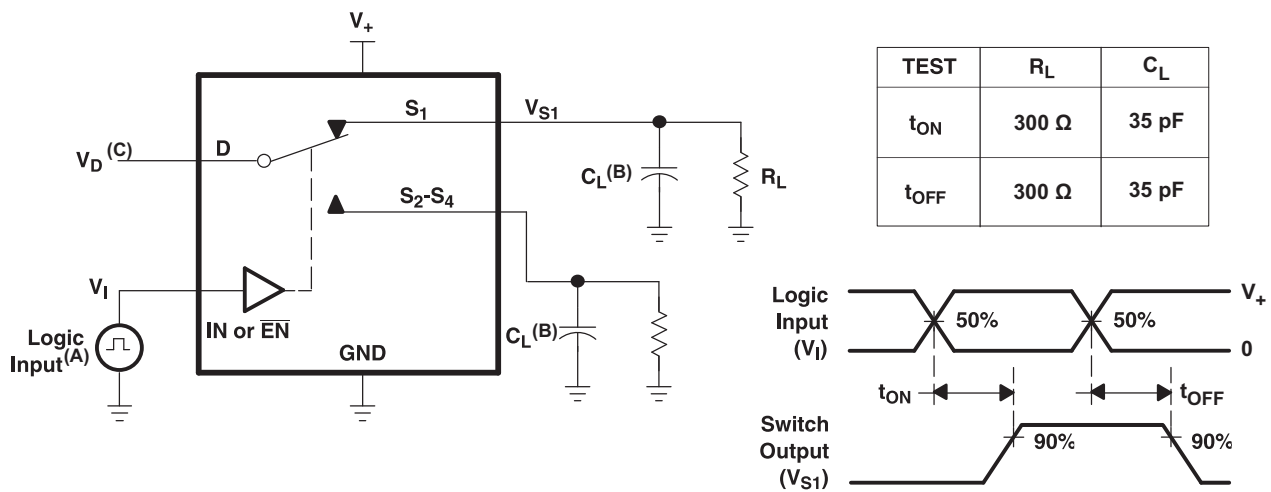


图 15. Capacitance ( $C_I$ ,  $C_{D(OFF)}$ ,  $C_{D(ON)}$ ,  $C_{S(OFF)}$ ,  $C_{S(ON)}$ )



- A. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5$  ns,  $t_f < 5$  ns.
- B.  $C_L$  includes probe and jig capacitance.
- C. See Electrical Characteristics for  $V_D$ .

图 16. Turnon ( $t_{ON}$ ) and Turnoff Time ( $t_{OFF}$ )

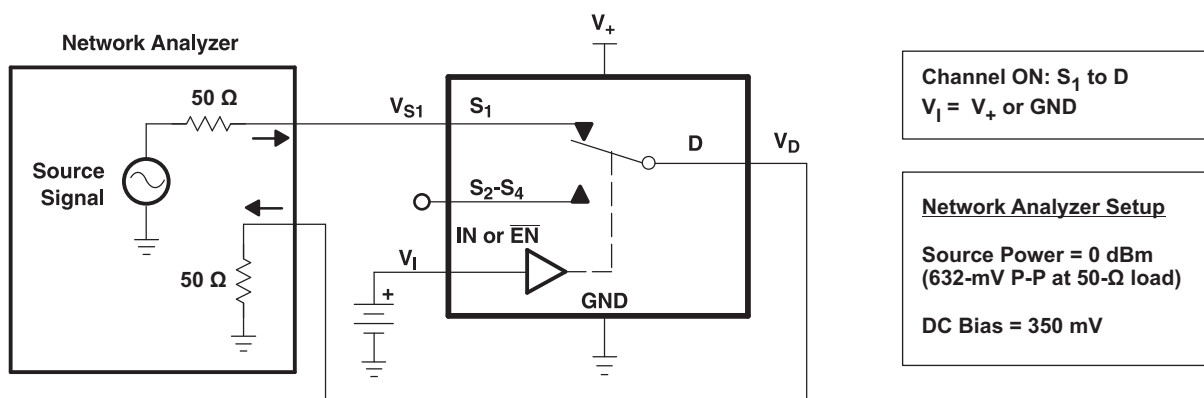


图 17. Bandwidth (BW)

Parameter Measurement Information (接下页)

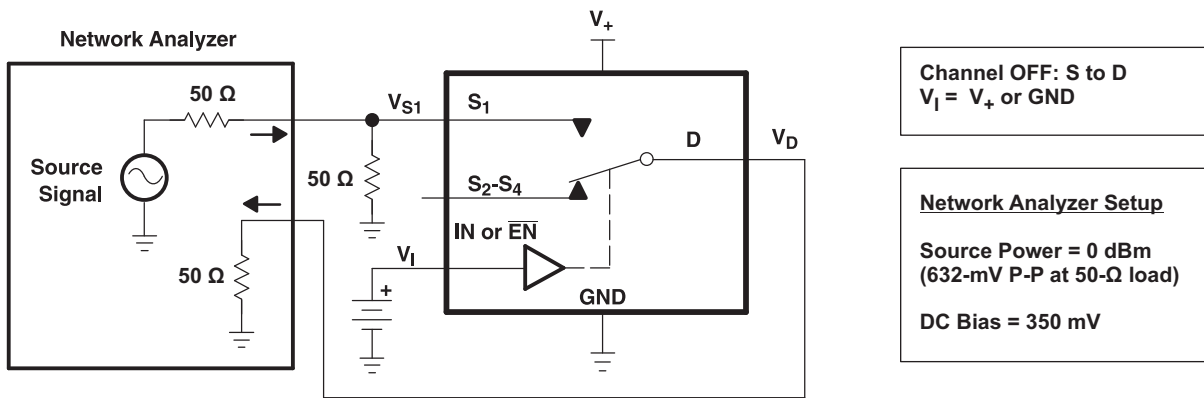


图 18. OFF Isolation ( $O_{ISO}$ )

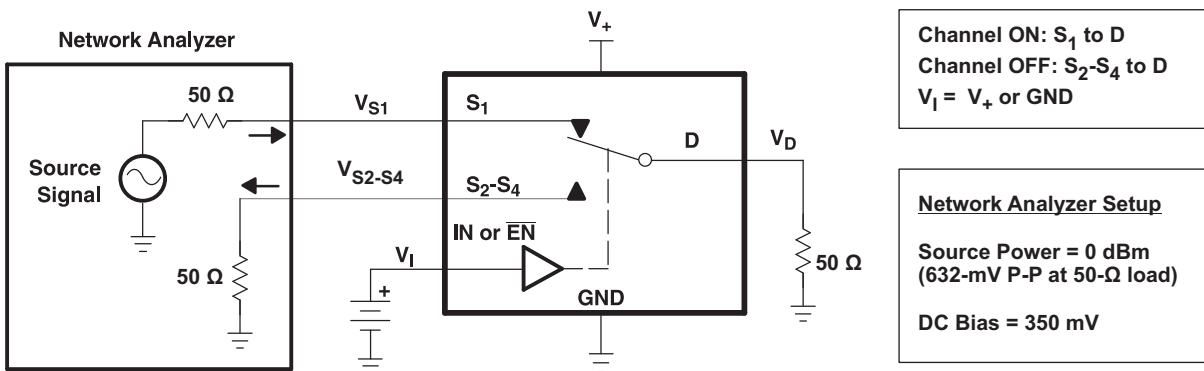


图 19. Crosstalk ( $X_{TALK}$ )

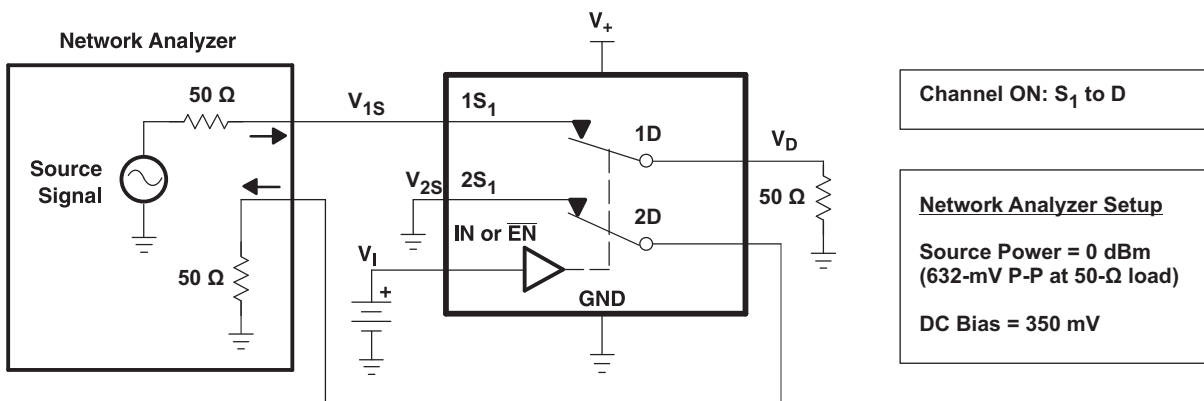
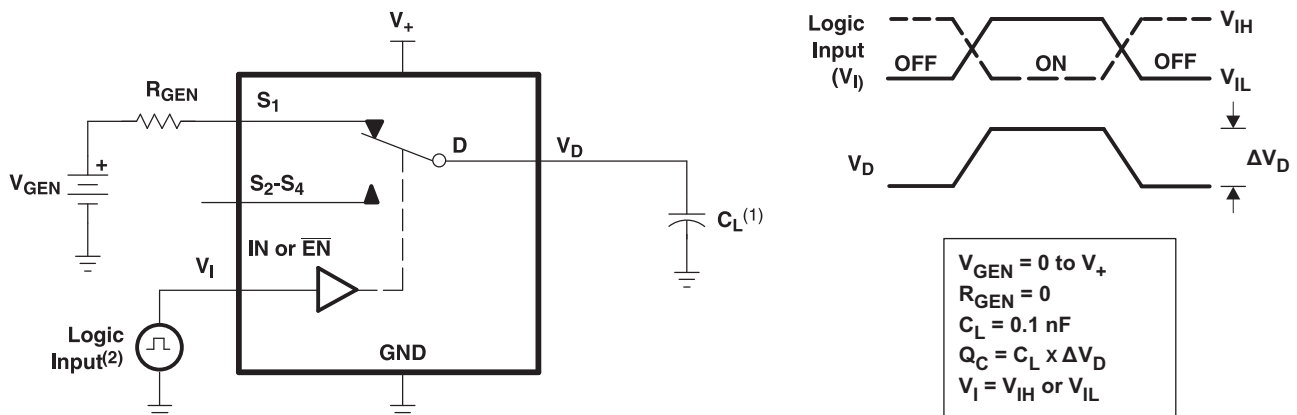


图 20. Adjacent Crosstalk ( $X_{TALK}$ )

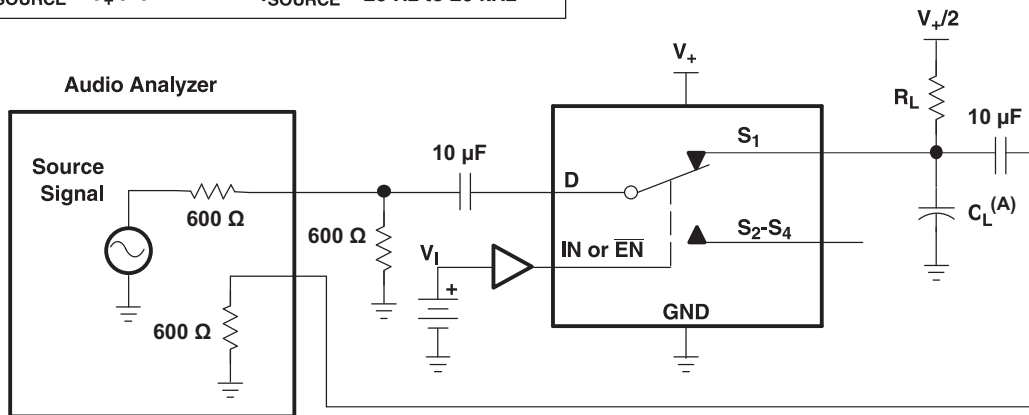
Parameter Measurement Information (接下页)



- A. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω, t<sub>r</sub> < 5 ns, t<sub>f</sub> < 5 ns.
- B. C<sub>L</sub> includes probe and jig capacitance.

图 21. Charge Injection (Q<sub>C</sub>)

Channel ON: D to S      V<sub>I</sub> = V<sub>IH</sub> or V<sub>IL</sub>  
 V<sub>SOURCE</sub> = V<sub>+</sub> P-P      f<sub>SOURCE</sub> = 20 Hz to 20 kHz



- A. C<sub>L</sub> includes probe and jig capacitance.

图 22. Total Harmonic Distortion (THD)

## 8 Detailed Description

### 8.1 Overview

The TS3A5017-Q1 is a dual Single-Pole-4-Throw (SP4T) solid-state analog switch. The TS3A5017-Q1, like all analog switches, is bidirectional. Each D pin connects to its four respective S pins, with the switch connection dependent on the status of  $\overline{\text{EN}}$ , IN2, and IN1. See [表 1](#) for the switch configuration truth table.

### 8.2 Functional Block Diagram

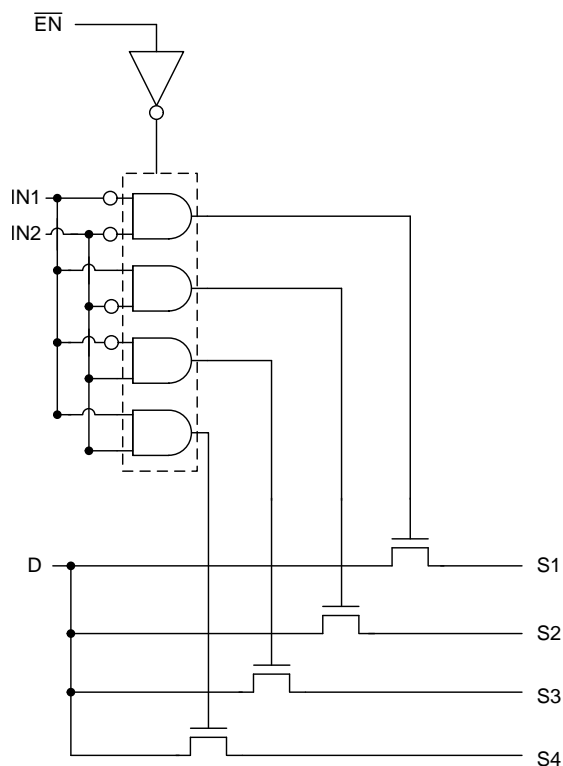


图 23. Functional Block Diagram (Each Switch)

### 8.3 Feature Description

Isolation in powered-down mode allows signals to be present at the inputs while the switch is powered off without causing damage to the device. The low ON-state resistance and low charge injection give the TS3A5017-Q1 better performance at higher speeds.

### 8.4 Device Functional Modes

表 1. Function Table

$\overline{\text{EN}}$	IN2	IN1	D TO S, S TO D
L	L	L	D = S <sub>1</sub>
L	L	H	D = S <sub>2</sub>
L	H	L	D = S <sub>3</sub>
L	H	H	D = S <sub>4</sub>
H	X	X	OFF

## 9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TS3A5017-Q1 can be used in a variety of customer systems. The TS3A5017-Q1 can be used anywhere multiple analog or digital signals must be selected to pass across a single line.

### 9.2 Typical Application

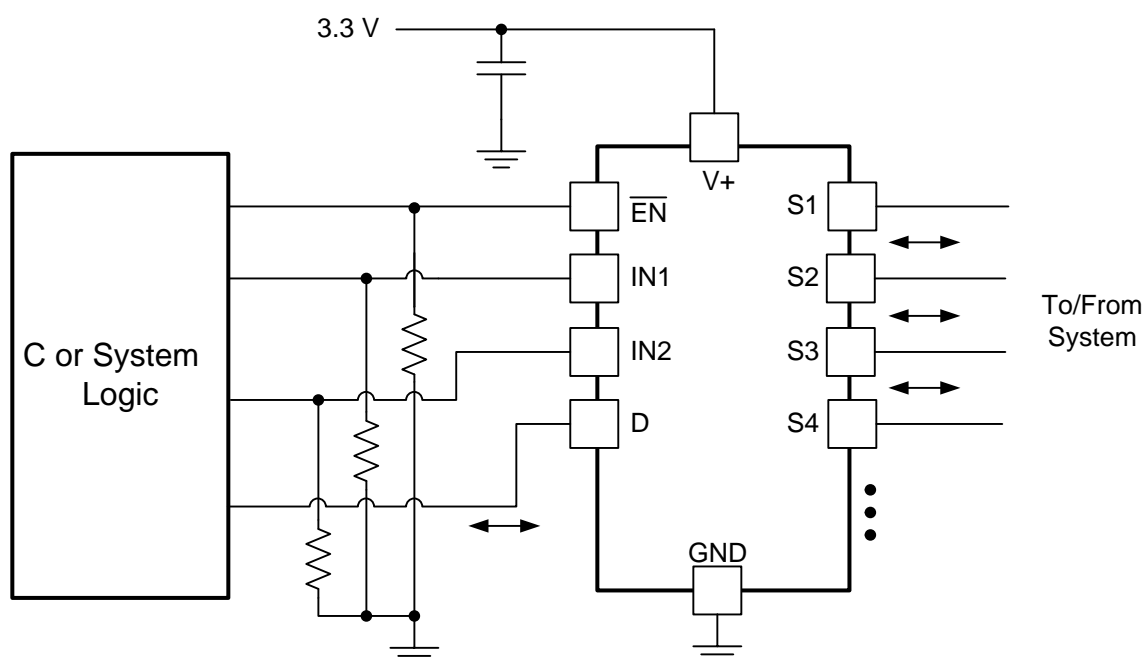


图 24. System Schematic for TS3A5017-Q1

#### 9.2.1 Design Requirements

In this particular application,  $V+$  was 3.3 V, although  $V+$  is allowed to be any voltage specified in *Recommended Operating Conditions*. A decoupling capacitor is recommended on the  $V+$  pin. See [Power Supply Recommendations](#) for more details.

#### 9.2.2 Detailed Design Procedure

In this application,  $\overline{EN}$ , IN1, and IN2 are, by default, pulled low to GND. Choose these resistor sizes based on the current driving strength of the GPIO, the desired power consumption, and the switching frequency (if applicable). If the GPIO is open-drain, use pullup resistors instead.



## Typical Application (接下页)

### 9.2.3 Application Curve

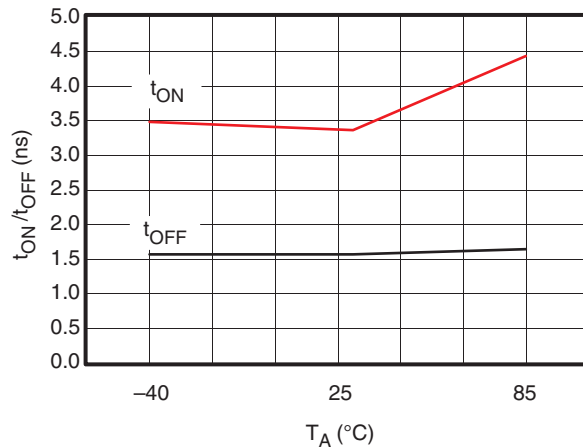


图 25. t<sub>ON</sub> and t<sub>OFF</sub> vs Temperature (V<sub>+</sub> = 3.3 V)

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operation Conditions*.

Each V<sub>CC</sub> terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1-μF bypass capacitor is recommended. If there are multiple pins labeled V<sub>CC</sub>, then a 0.01-μF or 0.022-μF capacitor is recommended for each V<sub>CC</sub> because the V<sub>CC</sub> pins will be tied together internally. For devices with dual-supply pins operating at different voltages, for example V<sub>CC</sub> and V<sub>DD</sub>, a 0.1-μF bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1-μF and 1-μF capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

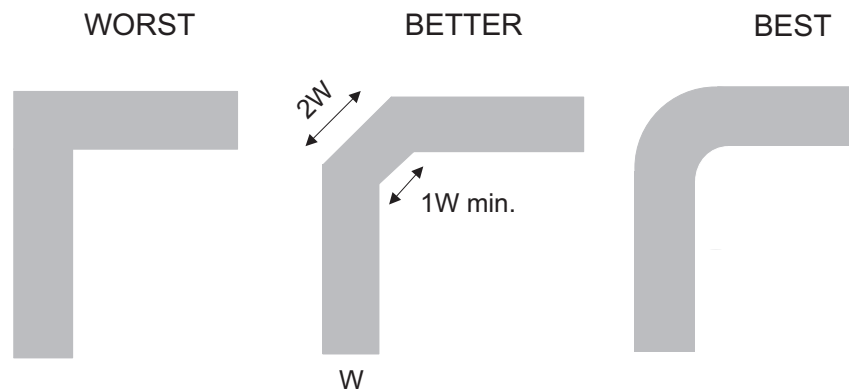
## 11 Layout

### 11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and the traces will turn corners. [图 26](#) shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

Unused switch I/Os, such as NO, NC, and COM, can be left floating or tied to GND. However, the IN1, IN2, and  $\overline{\text{EN}}$  pins must be driven high or low. Due to partial transistor turnon when control inputs are at threshold levels, floating control inputs can cause increased  $I_{\text{CC}}$  or unknown switch selection states. See *Implications of Slow or Floating CMOS Inputs*, [SCBA004](#) for more details.

### 11.2 Layout Example



**图 26. Trace Example**

## 12 器件和文档支持

### 12.1 器件支持

#### 12.1.1 器件命名规则

**表 2. 参数 说明**

符号	说明
$V_{COM}$	COM 处的电压
$V_{NC}$	NC 处的电压
$V_{NO}$	NO 处的电压
$r_{on}$	通道打开时 COM 和 NC 或 NO 端口之间的电阻
$\Delta r_{on}$	特定器件中通道间 $r_{on}$ 的差值
$r_{on(Flat)}$	额定条件范围内, 同一通道内 $r_{on}$ 最大值与最小值之间的差值
$I_{NC(OFF)}$	相应通道 (NC 到 COM) 处于关断状态时, 在 NC 端口测得的泄漏电流
$I_{NC(ON)}$	相应通道 (NC 到 COM) 处于导通状态且输出 (COM) 处于开路状态时, 在 NC 端口测得的泄漏电流
$I_{NO(OFF)}$	相应通道 (NO 到 COM) 处于关断状态时, 在 NO 端口测得的泄漏电流
$I_{NO(ON)}$	相应通道 (NO 到 COM) 处于导通状态且输出 (COM) 处于开路状态时, 在 NO 端口测得的泄漏电流
$I_{COM(OFF)}$	相应通道 (COM 到 NC 或 NO) 处于关断状态时, 在 COM 端口测得的泄漏电流
$I_{COM(ON)}$	相应通道 (COM 到 NC 或 NO) 处于导通状态且输出 (NC 或 NO) 处于开路状态时, 在 COM 端口测得的泄漏电流
$V_{IH}$	控制输入 (IN, $\overline{EN}$ ) 逻辑高电平的最小输入电压
$V_{IL}$	控制输入 (IN, $\overline{EN}$ ) 逻辑低电平的最大输入电压
$V_I$	控制输入 (IN, $\overline{EN}$ ) 处的电压
$I_{IH}, I_{IL}$	控制输入 (IN, $\overline{EN}$ ) 处测量的泄漏电流
$t_{ON}$	开关开通时间。此参数是在特定条件范围内, 开关开通时, 通过数字控制 (IN) 信号和模拟输出 (NC 或 NO) 信号之间的传播延迟测量得出。
$t_{OFF}$	开关关断时间。此参数是在特定条件范围内, 开关关断时, 通过数字控制 (OFF) 信号和模拟输出 (NC 或 NO) 信号之间的传播延迟测量得出。
$Q_C$	电荷注入是测量从控制 (IN) 输入到模拟 (NC 或 NO) 输入产生的不需要的信号耦合的方法。电荷注入以库仑为单位, 可通过测量开关控制输入产生的总感应电荷得出该值。电荷注入, $Q_C = C_L \times \Delta V_{COM}$ , $C_L$ 是负载电容, $\Delta V_{COM}$ 是模拟输出电压的变化。
$C_{NC(OFF)}$	相应通道 (NC 到 COM) 关闭时 NC 端口的电容
$C_{NC(ON)}$	相应通道 (NC 到 COM) 开启时 NC 端口的电容
$C_{NO(OFF)}$	相应通道 (NO 到 COM) 关闭时 NO 端口的电容
$C_{NO(ON)}$	相应通道 (NO 到 COM) 开启时 NO 端口的电容
$C_{COM(OFF)}$	相应通道 (COM 到 NC) 关闭时 COM 端口的电容
$C_{COM(ON)}$	相应通道 (COM 到 NC) 开启时 COM 端口的电容
$C_I$	控制输入 (IN, $\overline{EN}$ ) 电容
$O_{ISO}$	开关关断隔离用于衡量关断状态开关阻抗的大小。关断隔离以 dB 为单位, 当相应通道 (NC 到 COM) 处于关断状态时, 在额定频率下测量得出。
$X_{TALK}$	串扰是测量从开启状态的通道到关断状态的通道 (NC1 到 NO1) 产生的不必要信号耦合的方法。相邻串扰是测量从一条开启状态的通道到相邻开启状态的通道 (NC1 到 NC2) 产生的不必要信号耦合的方法。相邻串扰在额定频率下测量得出且以 dB 为单位。
BW	开关带宽。这是导通通道增益低于直流增益 -3dB 时的频率。
THD	总谐波失真用于描述由模拟开关导致的信号失真。其定义为二次、三次和更高次谐波与基波绝对幅度之比的均方根 (RMS) 值。
$I_+$	静态电源电流, 以及 $V_+$ 或 GND 的控制 (IN) 引脚

### 12.2 文档支持

#### 12.2.1 相关文档

- 《慢速或浮点 CMOS 输入的影响》, [SCBA004](#)

### 12.3 接收文档更新通知

要接收文档更新通知，请导航至 [TI.com.cn](http://TI.com.cn) 上的器件产品文件夹。单击右上角的 [通知我](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 12.4 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [《使用条款》](#)。

**TI E2E™ 在线社区** [TI 的工程师对工程师 \(E2E\) 社区](#)。此社区的创建目的在于促进工程师之间的协作。在 [e2e.ti.com](http://e2e.ti.com) 中，您可以咨询问题、分享知识、拓展思路并与同行工程师一道帮助解决问题。

**设计支持** [TI 参考设计支持](#) 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

### 12.5 商标

E2E is a trademark of Texas Instruments.

### 12.6 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

### 12.7 术语表

[SLYZ022](#) — *TI 术语表*。

这份术语表列出并解释术语、缩写和定义。

## 13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更，恕不另行通知，且不会对此文档进行修订。如需获取此数据表的浏览器版本，请查阅左侧的导航栏。

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邮寄地址：上海市浦东新区世纪大道 1568 号中建大厦 32 楼，邮政编码：200122  
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**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TS3A5017QRGYRQ1	ACTIVE	VQFN	RGY	16	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	5017Q	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "-" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. QFN (Quad Flatpack No-Lead) package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - F. Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
  - G. Package complies to JEDEC MO-241 variation BA.

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